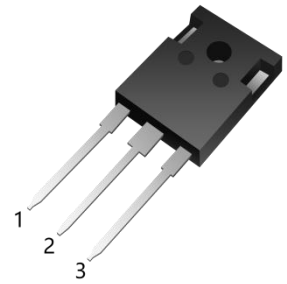
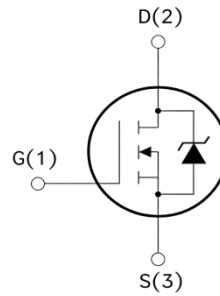


Silicon Carbide Power MOSFET

Parameter	Value	Unit
V_{DS}	1700	V
I_D	40	A
$R_{DS(ON)}$	72	m Ω
Q_G	100	nC



TO-247-3L

Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low $R_{DS(on)}$
- Low impedance package with driver source pin
- Easy to parallel and simple to drive

Applications

- EV Charging
- High Voltage DC/DC Converters
- Switched-Mode Power Supply(SMPS)
- Power Factor Correction(PFC)

Absolute Maximum Ratings (at $T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-source Voltage	V_{DS}	1700	V
Gate-source Voltage	V_{GS}	-10/+22	V
Drain Current (continuous; $T_c=25^\circ\text{C}$)	I_D	40	A
Drain Current (continuous; $T_c=100^\circ\text{C}$)		28	
Drain Current (pulsed)	I_{DM}	118	A
Power Dissipation ($T_c=25^\circ\text{C}$)	P_D	242	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to +175	$^\circ\text{C}$
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.62	$^\circ\text{C/W}$
Thermal Resistance From Junction to Ambient	$R_{\theta JA}$	40	

Electrical Characteristics

Parameter	Symbol	Conditions	Value			Unit
			Min.	Typ.	Max.	
Static characteristics (at $T_C=25^\circ\text{C}$ unless otherwise specified)						
Drain-Source Breakdown Voltage	$B_{V_{DS}}$	$V_{GS}=0V; I_D=250\mu A$	1700	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=1700V; V_{GS}=0V$	-	5	100	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=-10/+20V; V_{DS}=0V$	-	10	150	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}; I_{DS}=10mA$	2	3	4	V
Recommended Turn-on Voltage	$V_{GS(on)}$	Static	-	18	-	V
Recommended Turn-off Voltage	$V_{GS(off)}$		-	-5	-	V
Static Drain-Source on Resistance	$R_{DS(on)}$	$V_{GS}=18V; I_D=20A$	-	72	88	m Ω
		$V_{GS}=18V; I_D=20A; T_J=175^\circ\text{C}$	-	130	-	
Dynamic characteristics (at $T_C=25^\circ\text{C}$ unless otherwise specified)						
Input Capacitance	C_{iss}	$V_{DS}=1000V; f=1MHz; V_{AC}=25mV$	-	1550	-	pF
Output Capacitance	C_{oss}		-	138	-	
Reverse Transfer Capacitance	C_{rss}		-	20	-	
Transconductance	g_{fs}	$V_{DS}=20V; I_D=18A$	-	12	-	S
C_{OSS} Stored Energy	E_{OSS}	$V_{DS}=1000V; f=1MHz$	-	60	-	μJ
Turn-on Energy	E_{on}	$V_{DS}=1000V; V_{GS}=-5/+18V; I_D=25A; R_{g(ext)}=4.7\Omega; \text{Load}=150\mu H; T_J=175^\circ\text{C}$	-	950	-	μJ
Turn-off Energy	E_{off}		-	200	-	
Total Gate Charge	Q_G	$V_{DS}=1000V; V_{GS}=-5/+18V; I_D=25A$	-	100	-	nC
Gate-Source Charge	Q_{GS}		-	45	-	
Gate-Drain Charge	Q_{GD}		-	22	-	
Internal Gate Resistor	R_{Gint}	$f=1MHz; V_{AC}=25mV$	-	3	-	Ω
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=1000V; V_{GS}=-5/+18V; I_D=25A; R_{g(ext)}=4.7\Omega; \text{Load}=150\mu H$	-	35	-	ns
Rise Time	t_r		-	22	-	
Turn-off Delay Time	$t_{d(off)}$		-	19	-	
Fall Time	t_f		-	15	-	

Reverse SiC Diode Characteristics(at $T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V; I_F=20A$	-	3.8	6	V
		$V_{GS}=0V; I_F=20A; T_J=175^\circ\text{C}$	-	3.5	6	
Continuous Diode Forward Current	I_S	$V_{GS}=0V; T_C=25^\circ\text{C}$	-	30.5	-	A
Reverse Recovery Time	t_{RR}	$V_R=1000V; V_{GS}=-5V; I_F=20A; di/dt=1000A/\mu s; T_J=175^\circ\text{C}$	-	36	-	ns
Reverse Recovery Charge	Q_{RR}		-	160	-	nC
Peak Reverse Recovery Current	I_{RRM}		-	10.5	-	A

Typical Characteristics

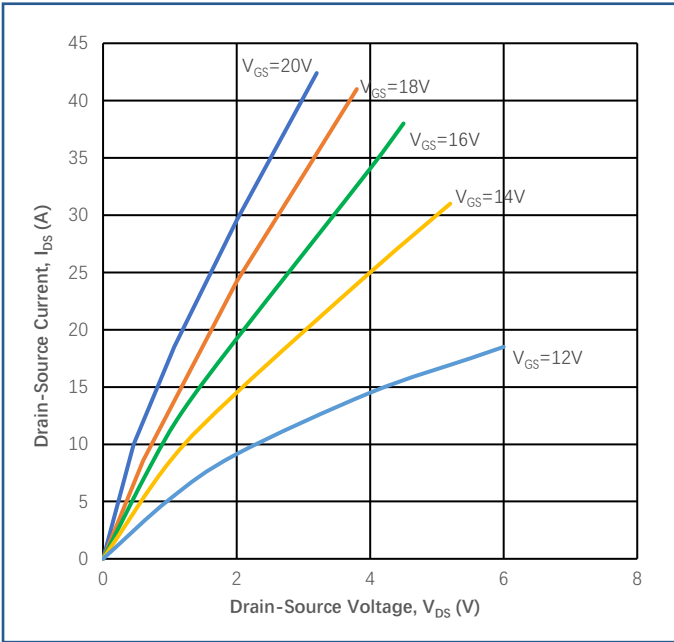


Fig 1
 Output Characteristics ($T_J=25\text{ }^\circ\text{C}$)

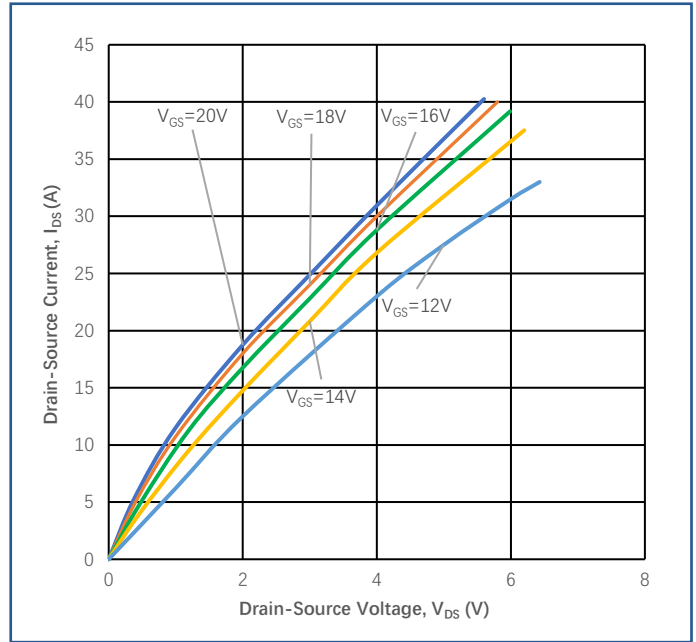


Fig 2
 Output Characteristics ($T_J=175\text{ }^\circ\text{C}$)

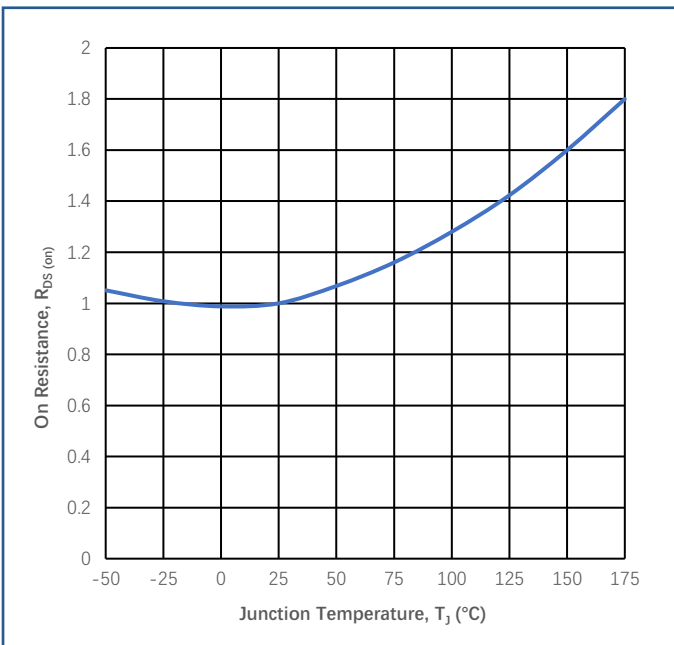


Fig 3
 Normalized On-Resistance vs. Temperature

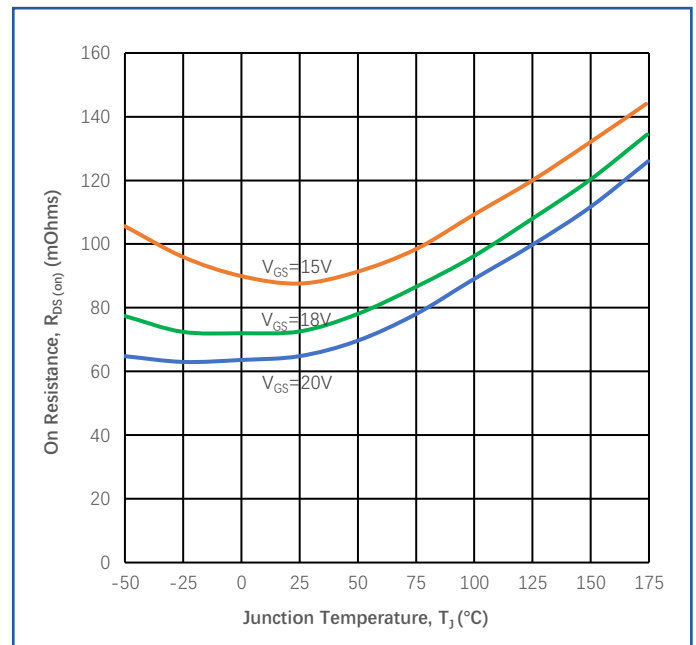


Fig 4
 On-Resistance vs. Temperature

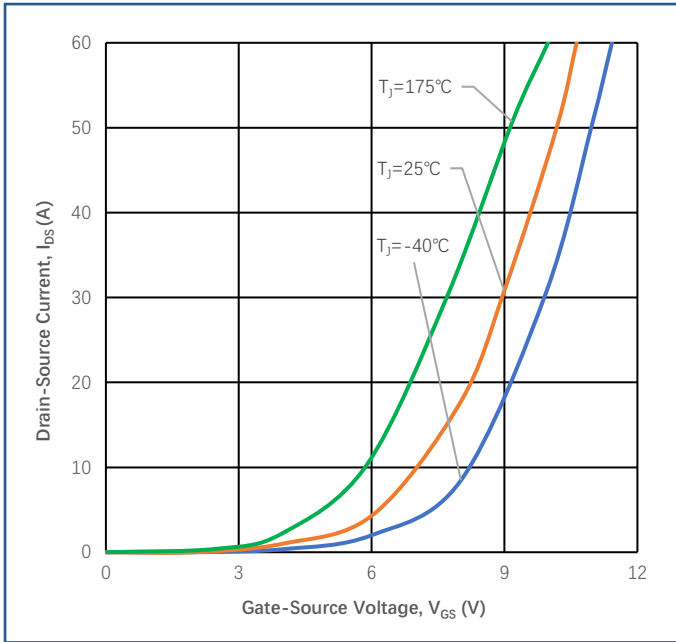


Fig 5
Transfer Characteristic

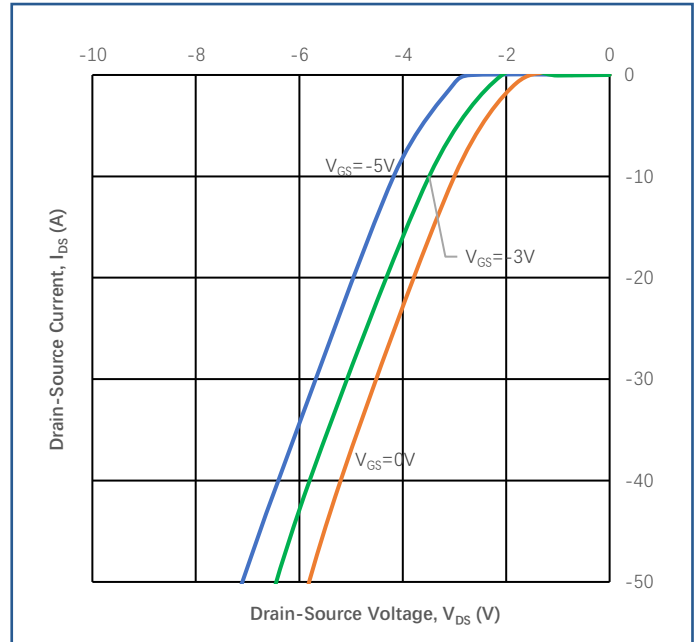


Fig 6
Body Diode Characteristic at 25°C

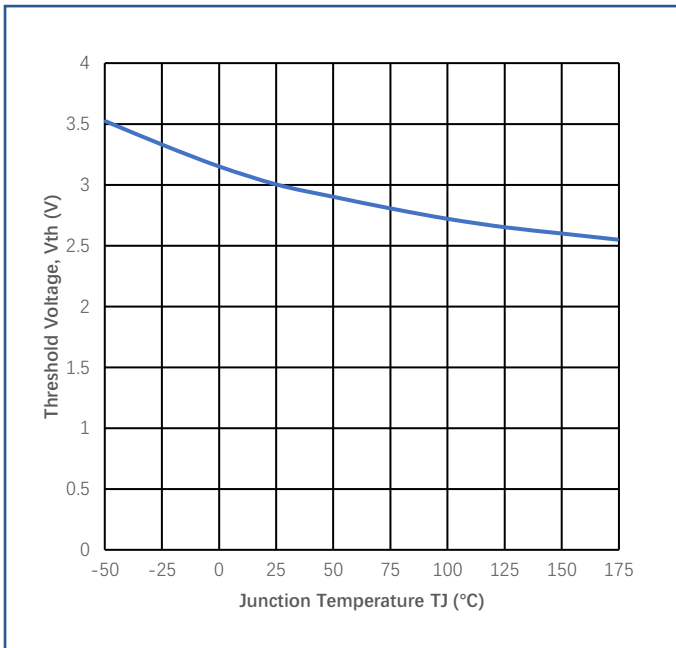


Fig 7
Threshold Voltage vs. Temperature

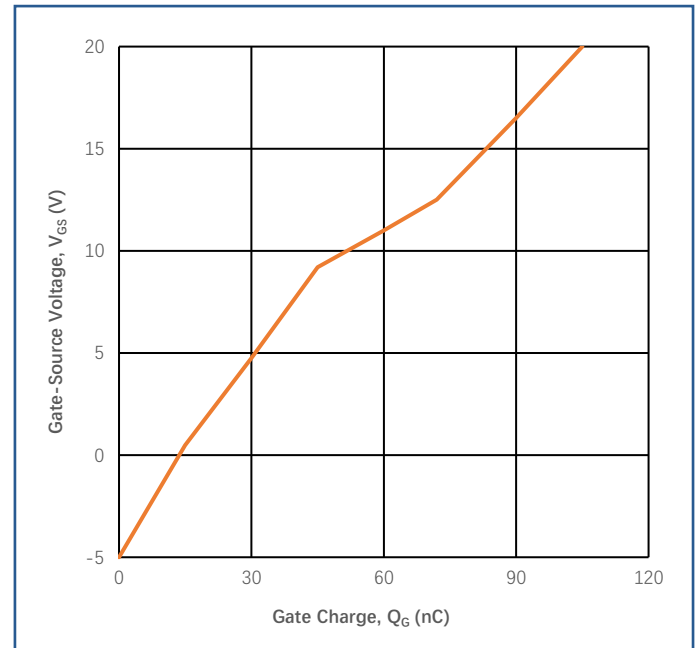


Fig 8
Gate Charge Characteristics

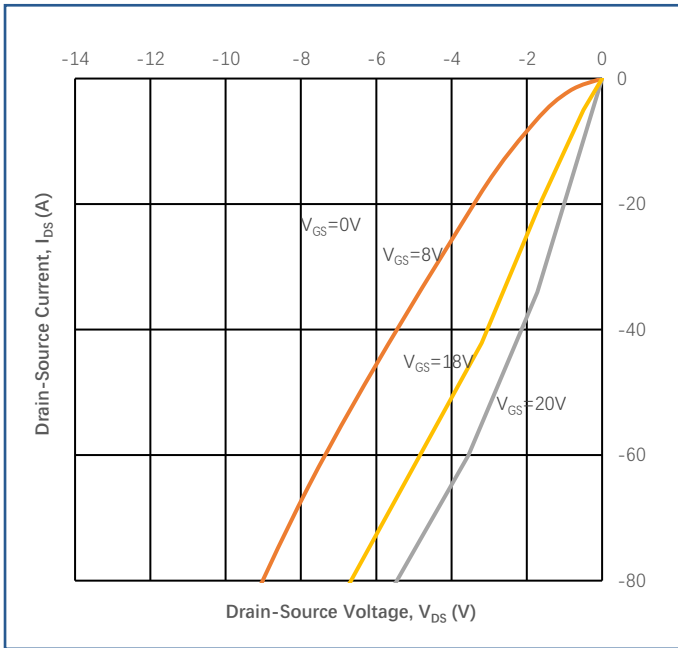


Fig 9
3rd Quadrant Characteristic at 25°C

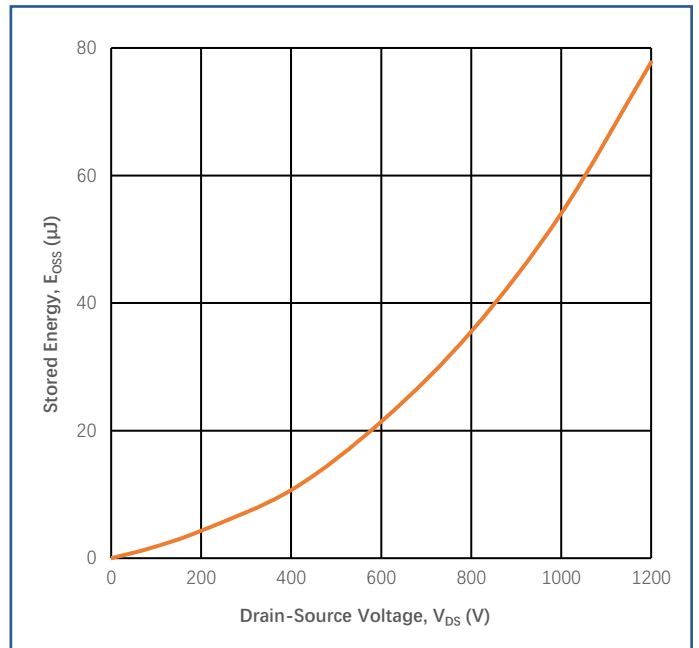


Fig 10
Output Capacitor Stored Energy

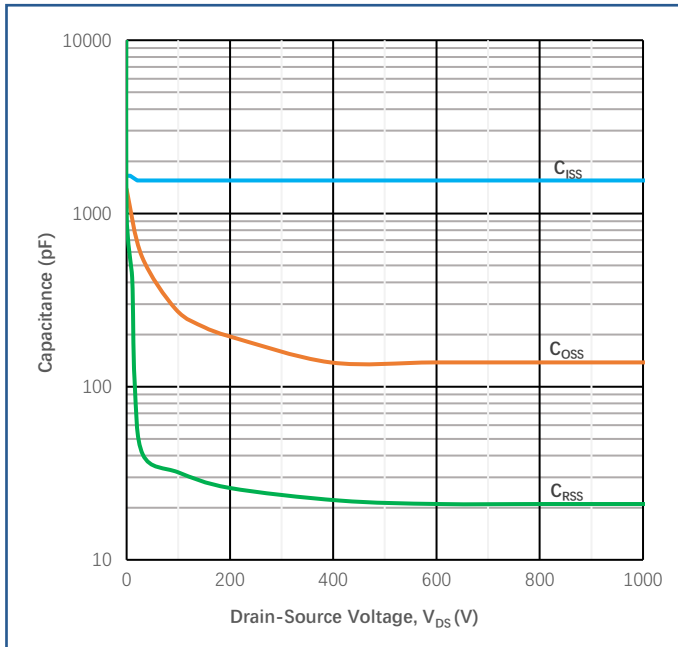


Fig 11
Capacitances vs. Drain-Source

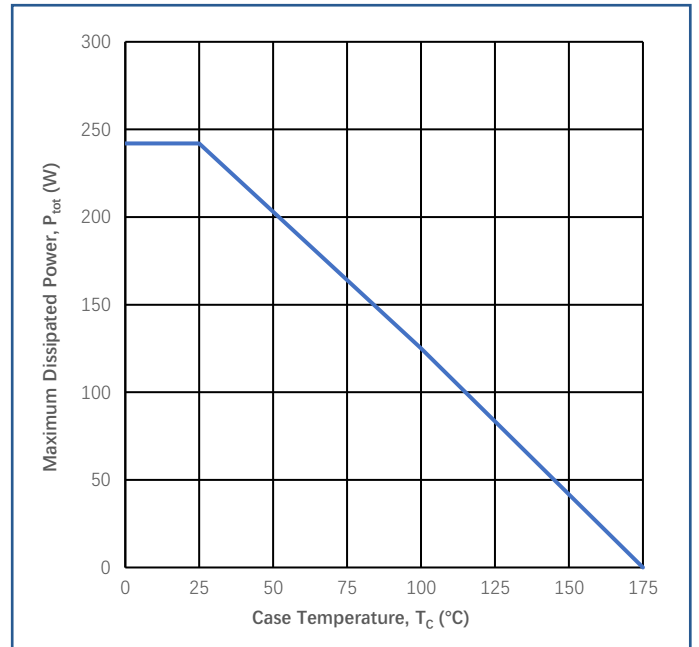


Fig 12
Max Power Dissipation Derating vs T_C

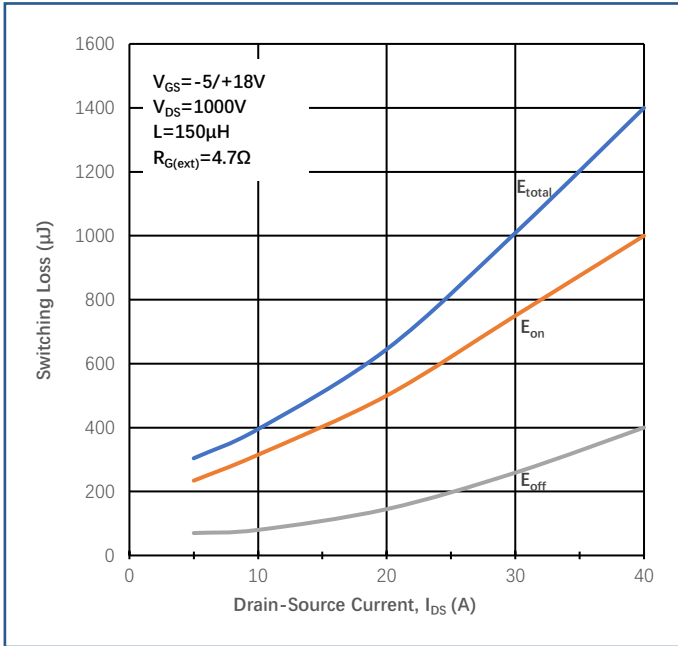


Fig 13

Switching Energy vs. Drain Current

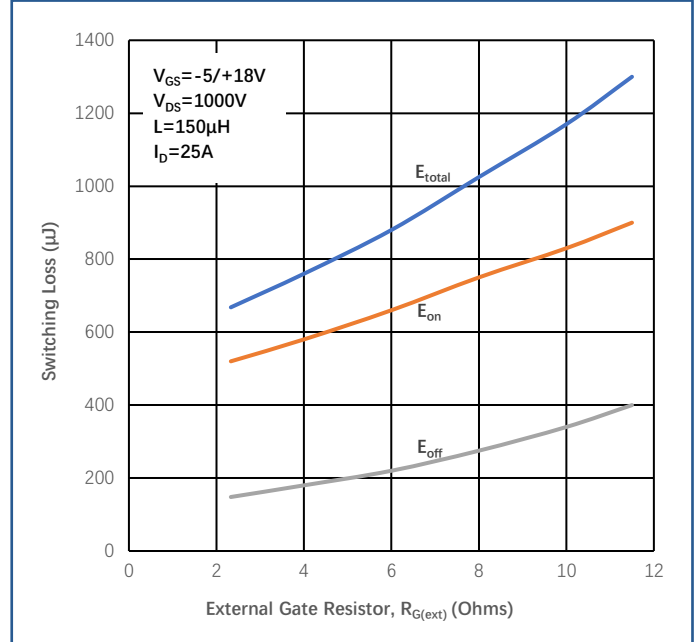


Fig 14

Switching Energy vs. $R_{G(ext)}$

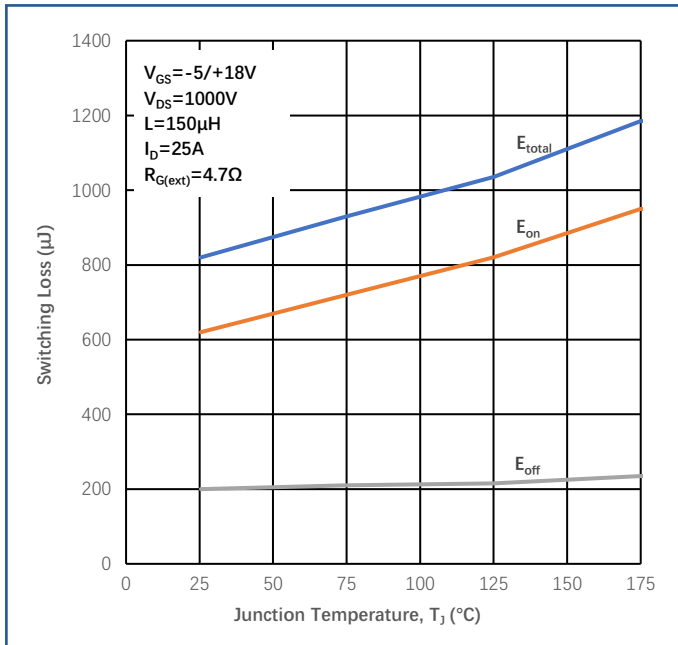


Fig 15

Switching Energy vs. Temperature

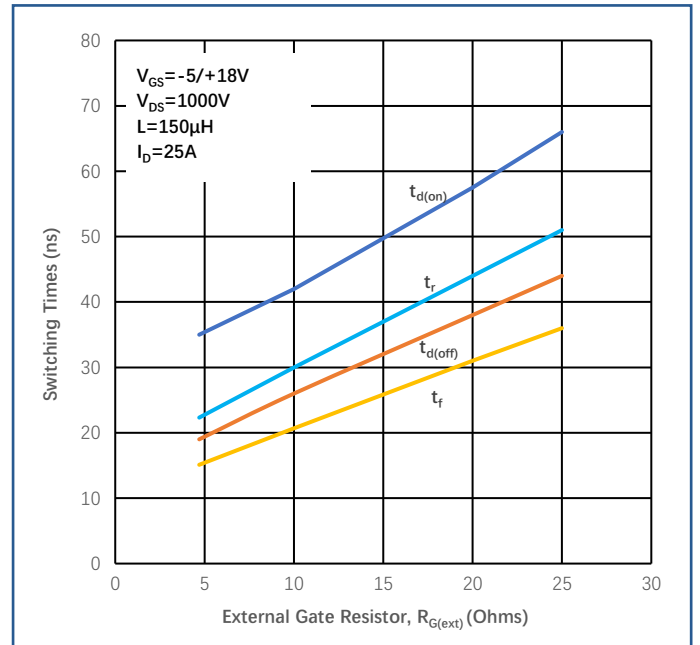


Fig 16

Switching Times vs. $R_{G(ext)}$

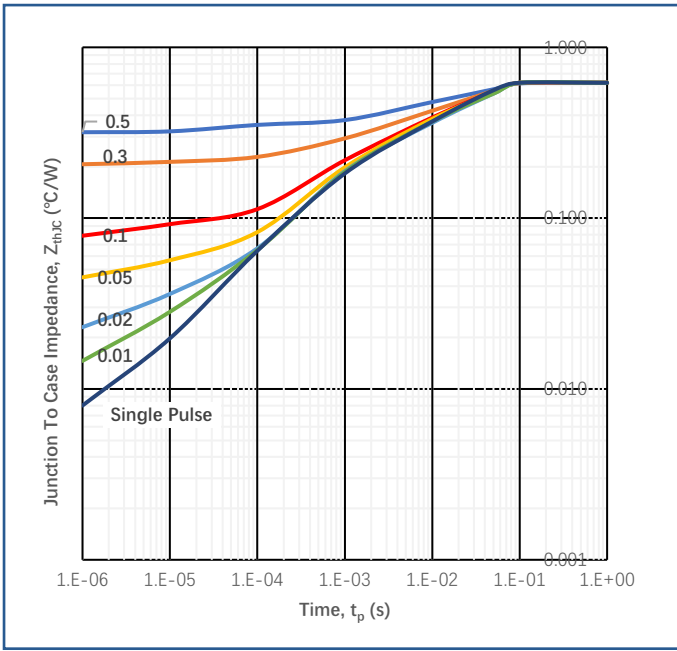


Fig 17

Transient Thermal Impedance

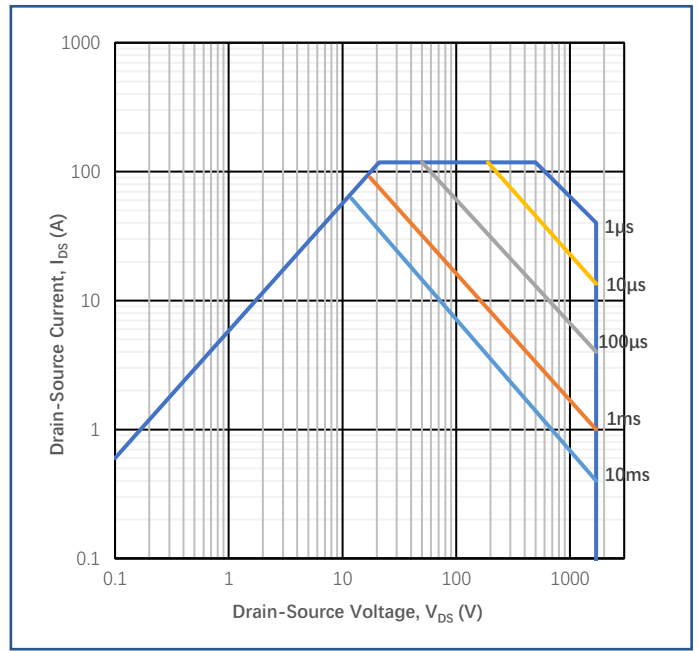
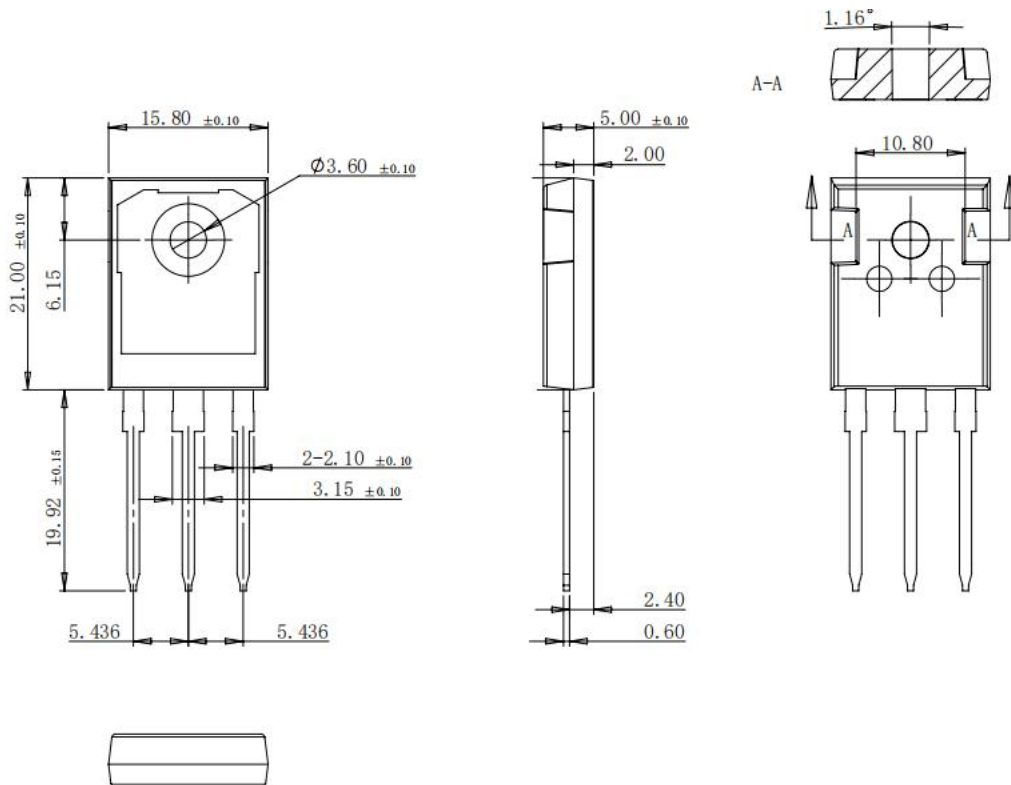


Fig 18

Safe Operating Area

Package Outlines(Unit:mm)

TO-247-3L



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